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Front Matter: Volume 10768

, "Front Matter: Volume 10768," Proc. SPIE 10768, Imaging Spectrometry XXII: Applications, Sensors, and Processing, 1076801 (5 November 2018); doi: 10.1117/12.2516446

SPIE.

Event: SPIE Optical Engineering + Applications, 2018, San Diego, California, United States

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Imaging Spectrometry XXII: Applications, Sensors, and Processing

**John F. Silny
Emmett J. Ientilucci**
Editors

**20 August 2018
San Diego, California, United States**

Sponsored and Published by
SPIE

Volume 10768

Proceedings of SPIE 0277-786X, V. 10768

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

Imaging Spectrometry XXII: Applications, Sensors, and Processing, edited by John F. Silny,
Emmett J. Ientilucci, Proc. of SPIE Vol. 10768, 1076801 · © 2018 SPIE
CCC code: 0277-786X/18/\$18 · doi: 10.1117/12.2516446

Proc. of SPIE Vol. 10768 1076801-1

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Author(s), "Title of Paper," in *Imaging Spectrometry XXII: Applications, Sensors, and Processing*, edited by John F. Silny, Emmett J. Ientilucci, Proceedings of SPIE Vol. 10768 (SPIE, Bellingham, WA, 2018) Seven-digit Article CID Number.

ISSN: 0277-786X
ISSN: 1996-756X (electronic)

ISBN: 9781510621077
ISBN: 9781510621084 (electronic)

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA
Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445

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